

<b>Notice of References Cited</b>	Application/Control No. 10/560,765		Applicant(s)/Patent Under Reexamination WIGDOR, DANIEL	
	Examiner DANIEL WALSH		Art Unit 2887	Page 1 of 4

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,758,267 A	05-1998	Pinder et al.	455/90.2
*	B	US-6,201,554 B1	03-2001	Lands, Robert M.	345/169
*	C	US-2001/0048423 A1	12-2001	REKIMOTO, JUNICHI	345/157
*	D	US-2002/0027549 A1	03-2002	Hirshberg, David	345/168
*	E	US-6,384,827 B1	05-2002	Dawkins, Derek F.	345/467
*	F	US-2002/0060699 A1	05-2002	D'Agostini, Giovanni	345/783
*	G	US-2002/0075335 A1	06-2002	Rekimoto, Junichi	345/864
*	H	US-6,433,793 B1	08-2002	Ootsuka, Katsuhiro	345/684
*	I	US-6,449,363 B1	09-2002	Kielsnia, Jean-Phillipe	379/420.01
*	J	US-2003/0038778 A1	02-2003	Noguera, Gritsko Perez	345/157
*	K	US-6,570,583 B1	05-2003	Kung et al.	345/661
*	L	US-2003/0107555 A1	06-2003	Williams, Roland E.	345/169
*	M	US-6,573,883 B1	06-2003	Bartlett, Joel F.	345/156

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**

Application/Control No.

10/560,765

Applicant(s)/Patent Under  
Reexamination  
WIGDOR, DANIEL

Examiner

DANIEL WALSH

Art Unit

2887

Page 2 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0134665 A1	07-2003	Kato et al.	455/566
*	B	US-6,597,345 B2	07-2003	Hirshberg, David	345/168
*	C	US-2004/0098266 A1	05-2004	Hughes et al.	704/277
*	D	US-6,731,227 B2	05-2004	Horie, Kenichi	341/22
*	E	US-2004/0130524 A1	07-2004	Matsui, Gantetsu	345/156
*	F	US-6,894,681 B2	05-2005	D'Agostini, Giovanni	345/173
*	G	US-6,933,923 B2	08-2005	Feinstein, David Y.	345/158
*	H	US-2005/0212757 A1	09-2005	Marvit et al.	345/156
*	I	US-2005/0212754 A1	09-2005	Marvit et al.	345/156
*	J	US-6,957,088 B2	10-2005	Kato et al.	455/566
*	K	US-2005/0247548 A1	11-2005	Levy, David H.	200/005.00R
*	L	US-2006/0007128 A1	01-2006	Fux et al.	345/156
*	M	US-2006/0103631 A1	05-2006	Mashima et al.	345/158

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**

Application/Control No.

10/560,765

Applicant(s)/Patent Under  
Reexamination  
WIGDOR, DANIEL

Examiner

DANIEL WALSH

Art Unit

2887

Page 3 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0094480 A1	05-2006	Tanaka, Motoshi	455/575.1
*	B	US-7,075,520 B2	07-2006	Williams, Roland E.	345/169
*	C	US-2006/0255139 A1	11-2006	Lee et al.	235/439
*	D	US-2006/0281453 A1	12-2006	Jaiswal et al.	455/423
*	E	US-2006/0284855 A1	12-2006	Shintome, Junichi	345/173
*	F	US-2007/0103431 A1	05-2007	Tabatowski-Bush, Benjamin Avery	345/156
*	G	US-2007/0139359 A1	06-2007	Voelckers, Oliver	345/156
*	H	US-2007/0180718 A1	08-2007	Fourquin et al.	033/366.11
*	I	US-2007/0259685 A1	11-2007	Engblom et al.	455/550.1
*	J	US-2007/0270178 A1	11-2007	Sohn et al.	455/550.1
*	K	US-7,301,528 B2	11-2007	Marvit et al.	345/156
*	L	US-2007/0252729 A1	11-2007	Li et al.	341/022
*	M	US-2007/0282468 A1	12-2007	Tsujino et al.	700/083

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**

Application/Control No.

10/560,765

Applicant(s)/Patent Under  
Reexamination  
WIGDOR, DANIEL

Examiner

DANIEL WALSH

Art Unit

2887

Page 4 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0012822 A1	01-2008	Sakhpara, Ketul	345/156
*	B	US-2008/0088600 A1	04-2008	Prest et al.	345/173
*	C	US-7,389,591 B2	06-2008	Jaiswal et al.	33/366.11
*	D	US-2008/0129552 A1	06-2008	Wigdor, Daniel	341/22
*	E	US-2008/0158024 A1	07-2008	Steiner et al.	341/34
*	F	US-2008/0204478 A1	08-2008	Hung, Kun-Chi	345/663
*	G	US-2008/0235965 A1	10-2008	JAISWAL et al.	33/366.11
*	H	US-2008/0263568 A1	10-2008	Kusuda et al.	719/320
*	I	US-2009/0055453 A1	02-2009	Wiggeshoff, Elke	708/145
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.